



IKEA of Sweden AB TEST REPORT

SCOPE OF WORK: FCC Part 15 subpart B – EMC report

Model: LED2019C2

REPORT NUMBER 201202060SHA-001

ISSUE DATE February 05, 2021

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Report no. 201202060SHA-001

Applicant	:	IKEA of Sweden AB Box 702, SE-343 81 Älmhult, SWEDEN
Manufacturer	:	LEEDARSON LIGHTING CO.,LTD. Xingtai Industrial Park, Economic Development Zone of Changtai County, Zhangzhou City, Fujian Province, CHINA
FCC ID	:	FHO-LED2019C2

Summary

The equipment complies with the requirements according to the following standard(s) or Specification: **47CFR Part 15 (2019):** Radio Frequency Devices (Subpart B)

ANSI C63.4 (2014): American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz

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Revision History

Report No.	Version	Description	Issued Date
201202060SHA-001	Rev. 01	Initial issue of report	February 05, 2021



Measurement result summary

TEST ITEM	FCC REFERANCE	TEST RESULT	NOTE
Conducted emission	15.107	Pass	
Radiation emission	15.109	Pass	

Notes: 1: NA =Not Applicable

2. Determination of the test conclusion is based on IEC Guide 115 in consideration of measurement uncertainty.

3: Additions, Deviations and Exclusions from Standards: None.

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1 GENERAL INFORMATION

1.1 Description of Equipment Under Test (EUT)

Product Name	:	Self-ballasted LED lamps
Type/Model	:	LED2019C2
Description of EUT	:	We tested it, and listed the worst data.
Rating	:	120V~, 60Hz, 1.8W, 18mA, E12
Brand name	:	IKEA
Category of EUT	:	Class B
EUT type	:	☐ Table top ☐ Floor standing
Sample received date	:	
Sample identification No.	:	0201216-14
Date of test	:	December 16-27, 2020

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1.2 Description of Test Facility

Name	:	Intertek Testing Services Shanghai
Address	:	Building 86, No. 1198 Qinzhou Road(North), Shanghai 200233, P.R. China
Telephone	:	86 21 61278200
Telefax	:	86 21 54262353
The test facility is recognized, certified, or accredited by these organizations		CNAS Accreditation Lab Registration No. CNAS L0139 FCC Accredited Lab Designation Number: CN1175 IC Registration Lab CAB identifier.: CN0051 VCCI Registration Lab Registration No.: R-14243, G-10845, C-14723, T-12252 A2LA Accreditation Lab Certificate Number: 3309.02

2.1 Standards or specification

47CFR Part 15 (2019): Radio Frequency Device: Subpart B

ANSI C63.4 (2014): Interim Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40GHz.

2.2 Mode of operation during the test

Within this test report, EUT was tested under all available operation modes and tested under its rating voltage and frequency. Other voltage and frequency is specified if used.

2.3 Test software list

Test Items	Software	Manufacturer	Version
Conducted emission	ESxS-K1	R&S	V2.1.0
Radiated emission	ES-K1	R&S	V1.71

2.4 Test peripherals list

ltem No.	Name	Band and Model	Description

2.5 Record of climatic conditions

Test Item	Temperature (°C)	Relative Humidity (%)	Pressure (Kpa)
Conducted emission	24	42	101
Radiated Emission	24	42	101

Notes: NA =Not Applicable

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<mark>Condւ</mark>	Conducted Emission				
Used	Equipment	Manufacturer	Туре	Internal no.	Due date
\boxtimes	Test Receiver	R&S	ESCS 30	EC 2107	2021-07-08
\boxtimes	A.M.N.	R&S	ESH2-Z5	EC 3119	2021-11-10
\boxtimes	Shielded room	Zhongyu	-	EC 2838	2022-01-12
Radia	ted Emission				
Used	Equipment	Manufacturer	Туре	Internal no.	Due date
\boxtimes	Test Receiver	R&S	ESIB 26	EC 3045	2021-09-16
\boxtimes	Bilog Antenna	TESEQ	CBL 6112D	EC 4206	2021-09-25
\boxtimes	Semi-anechoic chamber	Albatross project	-	EC 3048	2021-07-14
<mark>Additi</mark>	ional instrument				
Used	Equipment	Manufacturer	Туре	Internal no.	Due date
\boxtimes	Therom- Hygrograph	ZJ1-2A	S.M.I.F.	EC 3783	2021-03-03
\boxtimes	Therom- Hygrograph	ZJ1-2A	S.M.I.F.	EC 3481	2022-01-05

2.7 Measurement Uncertainty

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted emission at mains ports	9kHz ~ 150kHz	3.71 dB
conducted emission at mains ports	150kHz ~ 30MHz	3.31 dB
Radiated Emissions up to 1 GHz	30MHz ~ 1GHz	5.04 dB
	1GHz ~ 6GHz	4.97 dB
Radiated Emissions above 1 GHz	6GHz ~ 18GHz	5.29 dB

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Test result: PASS

3.1 Limits

3.1.1 Limits for conducted emission of class A device

Frequency range	Limits dB(µV)		
(MHz)	Quasi-peak	Average	
0.15 ~ 0.5	79	66	
0.5 ~ 30	73	60	
Note: If the limit for the measurement with the average detector is met when using a receiver with a			
quasi-peak detector, the equipment under test shall be deemed to meet both limits and the			

measurement using the receiver with an average detector need not be carried out.

3.1.2 Limits for conducted emission of class B device

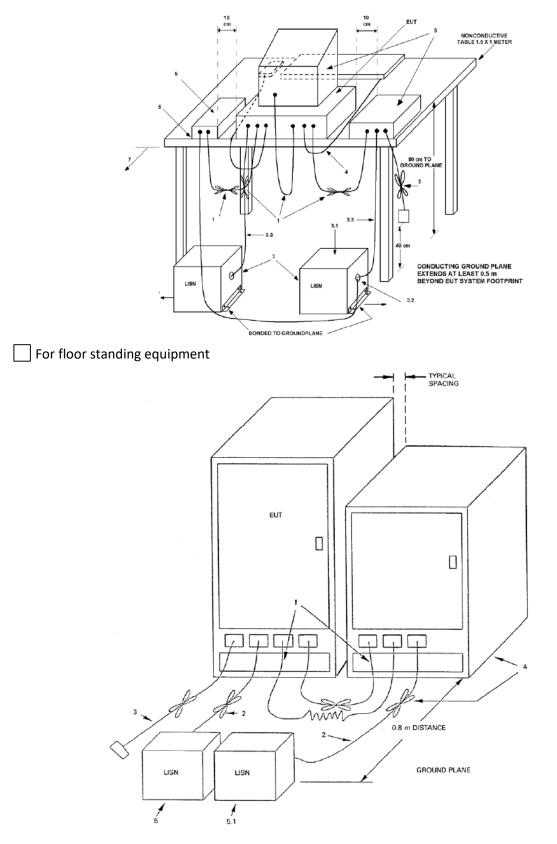
Frequency range	Limits dB(μV)			
(MHz)	Quasi-peak	Average		
0.15 ~ 0.5	66 ~ 56 *	56 ~ 46 *		
0.5 ~ 5	56	46		
5 ~ 30	60	50		
Note: 1. * Means the limit decreasing linearly with the logarithm of the frequency in the range 0.15MHz to 0.5MHz 2. If the limit for the measurement with the average detector is met when using a receiver with a quasi-peak detector, the equipment under test shall be deemed to meet both limits and the measurement using the receiver with an average detector need not be carried out.				

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3.2 Test setup

For table top equipment



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3.3 Test Setup and Test Procedure

Measurement was performed in shielded room, and instruments used were following clause 4 and clause 5 of ANSI 63.4.

Detailed test procedure was following clause 7.3 of ANSI 63.4.

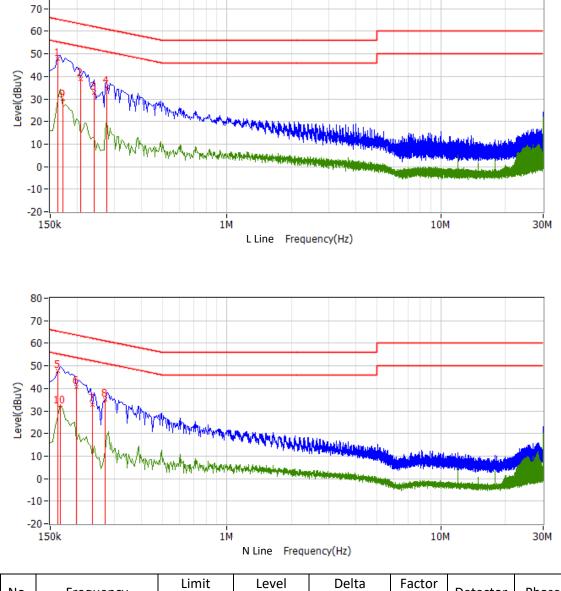
EUT arrangement and operation conditions were according to clause 6 and clause 7 of ANSI 63.4.

Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9 kHz.

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3.4 Test Protocol



No. Frequency	Limit	Level	Delta	Factor	Detector	Phase	
NO.	rrequeitcy	dBuV	dBuV	dB	dB	Delector	FIIdSe
1	163.500 kHz	65.3	47.7	-17.6	0.3	QP	L1
2	208.500 kHz	63.3	38.8	-24.5	0.3	QP	L1
3	240.000 kHz	62.1	32.8	-29.3	0.3	QP	L1
4	276.000 kHz	60.9	35.5	-25.4	0.3	QP	L1
5	163.500 kHz	65.3	47.8	-17.5	0.3	QP	Ν
6	199.500 kHz	63.6	40.8	-22.8	0.3	QP	Ν
7	235.500 kHz	62.3	32.8	-29.4	0.3	QP	Ν
8	271.500 kHz	61.1	35.0	-26.1	0.3	QP	Ν
9	172.500 kHz	54.8	29.3	-25.6	0.3	CAV	L1
10	168.000 kHz	55.1	31.9	-23.2	0.3	CAV	Ν

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- Remark: 1. Correct Factor = LISN Factor + Cable Loss, the value was added to Original Receiver Reading by the software automatically.
 - 2. Corrected Reading = Original Receiver Reading + Correct Factor
 - 3. Margin = Limit Corrected Reading
 - 4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming LISN Factor = 10.00dB, Cable Loss = 2.00dB,

Original Receiver Reading = 10.00dBuV, Limit = 66.00dBuV. Then Correct Factor = 10.00 + 2.00 = 12.00dB; Corrected Reading = 10dBuV + 12.00dB = 22.00dBuV; Margin = 66.00dBuV - 22.00dBuV = 44.00dB.



Test result: PASS

4.1 Radiated emission limits

4.1.1 Limits for radiated emission of class A device

Frequency (MHz)	Permitted limit in dBµV/m				
	(Quasi-peak)				
	of Measurement Distance 10m				
30 ~ 88	39				
88 ~ 216	43.5				
216 ~ 960	46.4				
Above 960	49.5				
Note: for the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10					
decades.					

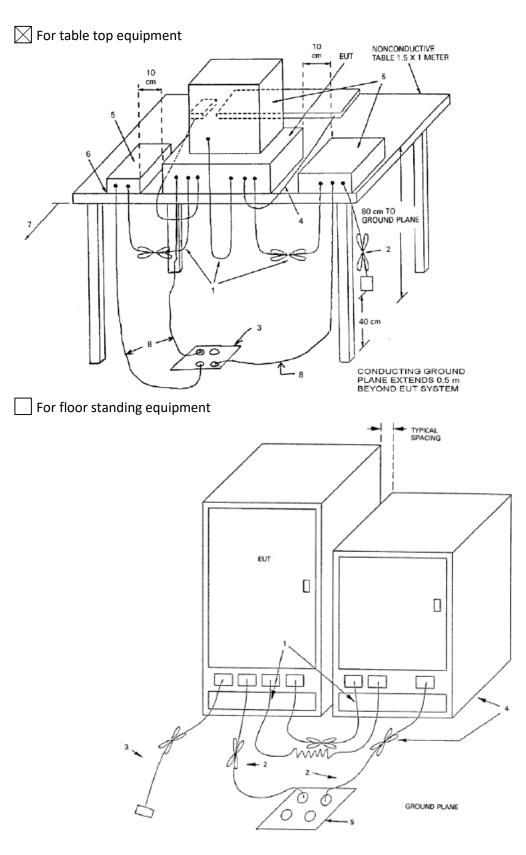
4.1.2 Limits for radiated emission of class B device

Frequency (MHz)	Permitted limit in dBµV/m (Quasi-peak) of Measurement Distance 3m			
30 ~ 88	40.0			
88 ~ 216				
	43.5			
216 ~ 960	46.0			
Above 960	54.0			
Note: for the measurement distance other than 3m and 10m, the limit is varied according to 20dB/10				
decades.				

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4.3 Test Setup and Test Procedure

The measurement was performed in a semi-anechoic chamber.

The distance from EUT to receiving antenna is 3 meter.

Measurement was performed according to clause 4 and clause 5 of ANSI 63.4.

Test procedure was according to clause 8.3 of ANSI 63.4.

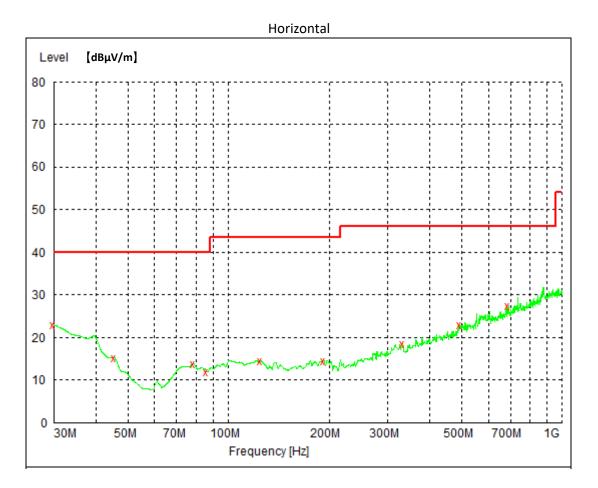
EUT arrangement and operate condition were according to clause 6 and clause 8 of ANSI 63.4.

The bandwidth setting on R&S Test Receiver was 120 kHz.

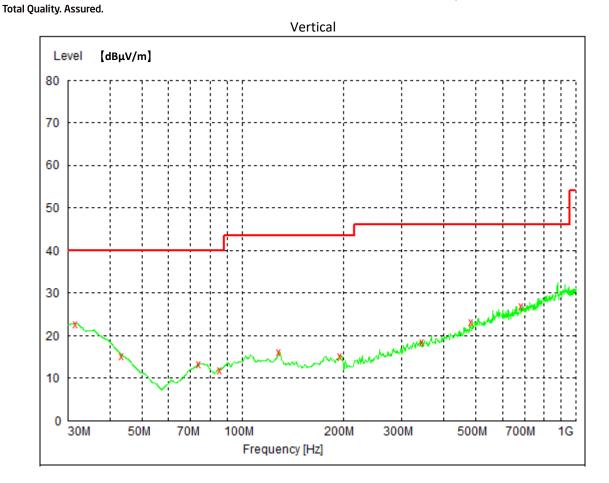
The required measurement frequency range was checked.

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Frequency	Level T	ransd	Limit	Margin
MHz dB	μV/m	dB dl	BμV/m	dB
30.000000	22.90	21.3	40.0	17.1
45.551102	15.30	12.5	40.0	24.7
78.597194	13.90	9.6	40.0	26.1
86.372745	11.90	10.1	40.0	28.1
125.250501	14.60	11.7	43.5	28.9
193.286573	14.60	11.2	43.5	28.9
333.246493	18.50	15.6	46.0	27.5
494.589178	22.90	19.5	46.0	23.1
688.977956	27.50	22.2	46.0	18.5



Frequency	Level T	ransd	Limit	Margin
MHz dB	μV/m	dB d	BμV/m	dB
	•		•	
31.943888	22.80	20.4	40.0	17.2
43.607214	15.30	13.9	40.0	24.7
74.709419	13.40	9.5	40.0	26.6
86.372745	12.00	10.1	40.0	28.0
129.138277	16.20	11.6	43.5	27.3
197.174349	15.20	11.2	43.5	28.3
346.853707	18.50	15.9	46.0	27.5
488.757515	23.30	19.1	46.0	22.7
688.977956	27.00	22.2	46.0	19.0

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Remark: 1.Correct Factor = Antenna Factor + Cable Loss (+ Amplifier, for higher than 1GHz) 2. Corrected Reading = Original Receiver Reading + Correct Factor

3. Margin = Limit - Corrected Reading

4. If the PK Corrected Reading is lower than AV limit, the AV test can be elided.

Example: Assuming Antenna Factor = 30.20dB/m, Cable Loss = 2.00dB,

Gain of Preamplifier = 32.00dB, Original Receiver Reading = 10.00dBuV, limit = 40.00dBuV/m. Then Correct Factor = 30.20 + 2.00 - 32.00 = 0.20dB/m; Corrected Reading = 10dBuV + 0.20dB/m = 10.20dBuV/m; Margin = 40.00dBuV/m - 10.20dBuV/m = 29.80dB.

END of the report